

<b>Notice of References Cited</b>	Application/Control No. 10/676,820		Applicant(s)/Patent Under Reexamination STEINBERG ET AL.	
	Examiner JOHN Wahnkyo LEE		Art Unit 2624	Page 1 of 1

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*	B	US-2002/0093577 A1	07-2002	Kitawaki et al.	348/241
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**NON-PATENT DOCUMENTS**

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